

Ref #	Hits	Search Query	DBs	Default Operator	Plurals	Time Stamp
S1	1245	361/91.5	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/09/22 09:27
S2	2176	inductive adj load and (FET MOSFET MOS (field adj effect))	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/02/11 09:32
S3	820	inductive adj load same (FET MOSFET MOS (field adj effect))	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/09/20 15:13
S4	43	inductive adj load same (FET MOSFET MOS (field adj effect)) and switch near gate	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/09/20 15:14
S5	3	inductive adj load same (FET MOSFET MOS (field adj effect)) and switch near gate near ground	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/09/20 15:58
S6	11	inductive adj load same (FET MOSFET MOS (field adj effect)) and switch same gate near ground	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/09/20 16:18
S7	16	("3979607" "5023692" "5028811" "5079608" "5115369" "5162966" "5264736" "5401996" "5764088" "5812006" "5828244" "5875089" "5963066" "6127746" "6201427" "6204715").PN.	USPAT	OR	ON	2004/09/20 15:26
S8	1	inductive adj load same igbt and switch same gate near ground	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/09/20 15:51
S9	1	"5500616".PN.	USPAT	OR	ON	2004/09/20 15:49
S10	3	"5500616".URPN.	USPAT	OR	ON	2004/09/20 15:49

S11	4	inductive adj load same igbt and switch same gate near resistor	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/09/20 15:52
S12	0	inductive adj load same (FET MOSFET MOS (field adj effect)) and chrage adj pump	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/09/20 15:59
S13	46	inductive adj load same (FET MOSFET MOS (field adj effect)) and charge adj pump	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/09/20 15:59
S14	4	inductive adj load same (FET MOSFET MOS (field adj effect)) and charge adj pump and gate near resistor	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/09/20 16:00
S15	778	361/91.1	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/09/20 16:19
S16	8	"5,828,244"	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/09/21 15:24
S17	7	("3742252" "4481434" "4631652" "4777387" "5126651" "5352932" "5371418").PN.	USPAT	OR	ON	2004/09/21 13:12
S18	0	esd same (FET MOS MOSFET) same gate near drain near resistor	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/09/21 13:15
S19	205	esd same (FET MOS MOSFET) same gate same drain same resistor	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/09/21 13:29
S20	299	transient same (FET MOS MOSFET) same gate same drain same resistor	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/09/21 13:30

S21	1	transient same (FET MOS MOSFET) same gate same drain near resistor	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/09/21 13:30
S22	34	transient same (FET MOS MOSFET) same gate near drain same resistor	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/09/21 13:31
S23	7	("3742252" "4481434" "4631652" "4777387" "5126651" "5352932" "5371418").PN.	USPAT	OR	ON	2004/09/21 13:49
S24	11	("4356416" "4459498" "4500801" "4677325" "4716309" "4719531" "4737667" "4816699" "4859875" "4928053" "4952827").PN.	USPAT	OR	ON	2004/09/21 13:51
S25	6	"5828244".URPN.	USPAT	OR	ON	2004/09/21 13:53
S26	126	esd and trigger adj circuit	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/09/21 13:54
S27	82	esd same trigger adj circuit	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/09/21 13:55
S28	0	esd same trigger adj circuit near resistor	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/09/21 13:55
S29	30	esd same trigger adj circuit same resistor	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/09/21 13:57
S30	436556	MOS MOSFET FET and bias adj resistor	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/09/21 13:58
S31	2193	(MOS MOSFET FET) and bias adj resistor	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/09/21 13:58

S32	837	(MOS MOSFET FET) same bias adj resistor	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/09/21 13:58
S33	38	(MOS MOSFET FET) same bias adj resistor same gate near drain	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/09/21 13:59
S34	0	(MOS MOSFET FET) same miller adj effect near resistor	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/09/21 14:00
S35	41	(MOS MOSFET FET) same miller adj effect same resistor	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/09/21 14:00
S36	5	("4916599" "5457624" "5552695" "5847554" "6304474").PN.	USPAT	OR	ON	2004/09/21 14:07
S37	3144	361/111	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/09/21 16:04
S38	2070	(FET MOSFET MOS (field adj effect)) near (protect protecting protection)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/02/10 15:14
S39	8	(FET MOSFET MOS (field adj effect)) near (protect protecting protection) near over adj voltage	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/02/10 15:25
S40	10	(FET MOSFET MOS (field adj effect)) near (protect protecting protection) near surge	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/02/10 15:26
S41	6	("4744369" "5079455" "5122724" "5374887" "5930130" "6438002").PN.	US-PGPUB; USPAT; USOCR	OR	ON	2005/02/10 15:30
S42	883	361/91.1	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT	OR	ON	2005/02/10 15:45

S43	3363	361/111	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT	OR	ON	2005/02/10 16:18
S44	1073	361/91.5	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/02/11 09:33